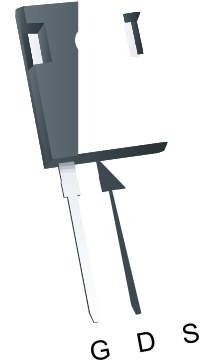


## N-Channel Super Junction Power MOSFET

### Feature

- 650V/35A  
 $R_{DS(ON)} = 95\text{ m}\Omega$  (typ.) @  $V_{GS} = 10\text{V}$
- 100% Avalanche Tested
- 100% DVDS
- Reliable and Rugged
- Halogen Free and Green Devices Available  
 (RoHS Compliant)

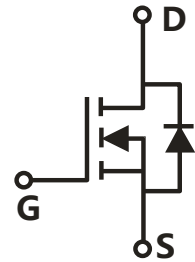
### Pin Description



TO-247A-3L


### Applications

- Solar/Renewable/UPS-Micro Inverter System
- Charger
- Power Supply



Single N-Channel MOSFET

### Ordering and Marking Information

 <p style="text-align: center;">             W              HY65R900              XYMXXXXXX         </p>	<p>Package Code              W:TO-247A-3L</p> <p>Date Code              XYMXXXXXX</p>
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Note: HUAYI halogen free products contain molding compounds/die attach materials and 100% matte tin plate Termination finish; which are fully compliant with RoHS. HUAYI halogen free products meet or exceed the halogen free requirements of IPC/JEDEC J-STD-020 for MSL classification at halogen free peak reflow temperature. HUAYI defines "Green" to mean halogen free (RoHS compliant) and halogen free (Br or Cl does not exceed 900ppm by weight in homogeneous material and total of Br and Cl does not exceed 1500ppm by weight).

HUAYI reserves the right to make changes, corrections, enhancements, modifications, and improvements to this product and/or to this document at any time without notice.

## Absolute Maximum Ratings

Symbol	Parameter	Rating	Unit	
<b>Common Ratings (Tc=25°C Unless Otherwise Noted)</b>				
V <sub>DSS</sub>	Drain-Source Voltage	650	V	
V <sub>GSS</sub>	Gate-Source Voltage	20	V	
T <sub>J</sub>	Junction Temperature Range	-55 to 175	°C	
T <sub>STG</sub>	Storage Temperature Range		°C	
I <sub>S</sub>	Source Current-Continuous(Body Diode)	Tc=25°C	35	A
<b>Mounted on Large Heat Sink</b>				
I <sub>DM</sub>	Pulsed Drain Current *	Tc=25°C	140	A
I <sub>D</sub>	Continuous Drain Current	Tc=25°C	35	A
		Tc=100°C	24.7	A
P <sub>D</sub>	Maximum Power Dissipation	Tc=25°C	375	W
		Tc=100°C	187.5	W
R <sub>θJC</sub>	Thermal Resistance, Junction-to-Case		0.4	°C/W
R <sub>θJA</sub>	Thermal Resistance, Junction-to-Ambient **		40	°C/W
E <sub>AS</sub>	Single Pulsed-Avalanche Energy ***	L=80mH	1372	mJ

Note: \* Repetitive rating pulse width limited by max.junction temperature.

\*\* Surface mounted on 1in2 FR-4 board.

\*\*\* Limited by T<sub>Jmax</sub>, starting T<sub>J</sub>=25°C, L = 80mH, R<sub>G</sub>= 25 Ω, V<sub>GS</sub>=10V.

## Electrical Characteristics(Tc =25°C Unless Otherwise Noted)

Symbol	Parameter	Test Conditions	HY65R900			Unit
			Min	Typ.	Max	
<b>Static Characteristics</b>						
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	V <sub>GS</sub> =0V, I <sub>DS</sub> =250μA	650	-	-	V
I <sub>DSS</sub>	Drain-to-Source Leakage Current	V <sub>DS</sub> =650V, V <sub>GS</sub> =0V	-	-	1	μA
		T <sub>J</sub> =125°C	-	-	50	μA
V <sub>GS(th)</sub>	Gate Threshold Voltage	V <sub>DS</sub> =V <sub>GS</sub> , I <sub>DS</sub> =250μA	3	4	5	V
I <sub>GSS</sub>	Gate-Source Leakage Current	V <sub>GS</sub> = 20V, V <sub>DS</sub> =0V	-	-	±100	nA
R <sub>DS(ON)</sub>	Drain-Source On-State Resistance	V <sub>GS</sub> =10V, I <sub>DS</sub> =20A	-	95	110	m
<b>Diode Characteristics</b>						
V <sub>SD</sub>	Diode Forward Voltage	I <sub>SD</sub> =35A, V <sub>GS</sub> =0V	-	0.98	1.3	V
t <sub>rr</sub>	Reverse Recovery Time	I <sub>SD</sub> =20A, dl				

## Electrical Characteristics (Cont.) (Tc =25°C Unless Otherwise Noted)

Symbol	Parameter	Test Conditions	HY65R900			Unit
			Min	Typ.	Max	
<b>Dynamic Characteristics</b>						
R <sub>G</sub>	Gate Resistance	V <sub>GS</sub> =0V, V <sub>DS</sub> =0V, F=100KHz	-	0.93	-	
C <sub>iss</sub>	Input Capacitance	V <sub>GS</sub> =0V, V <sub>DS</sub> =200V, Frequency=100KHz	-	2780	-	pF
C <sub>oss</sub>	Output Capacitance		-	80	-	
C <sub>rss</sub>						

## Typical Operating Characteristics

Figure 1: Power Dissipation

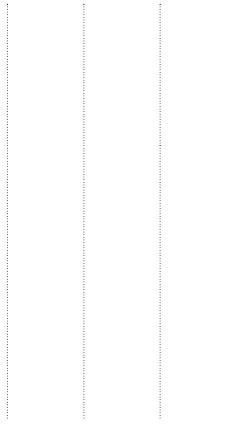


Figure 2: Drain Current

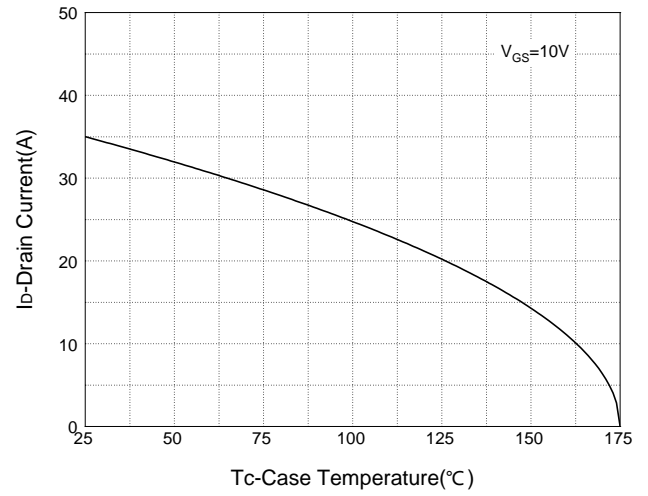


Figure 3: Safe Operation Area

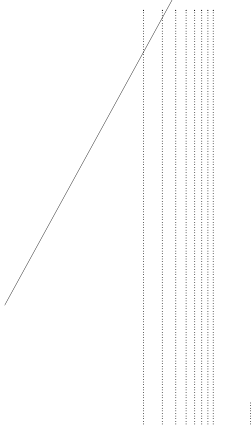


Figure 4: Thermal Transient Impedance

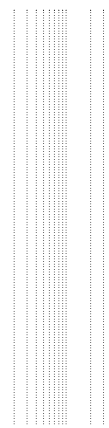


Figure 5: Output Characteristics

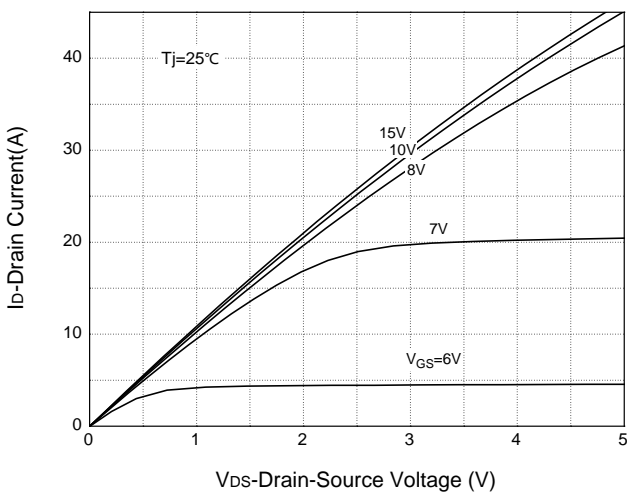
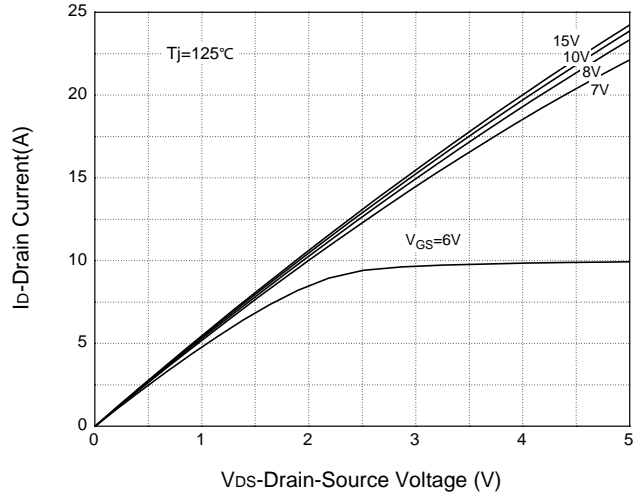
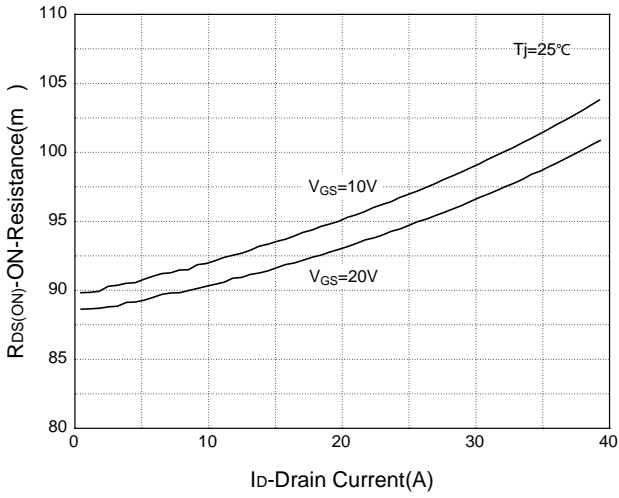


Figure 6: Output Characteristics

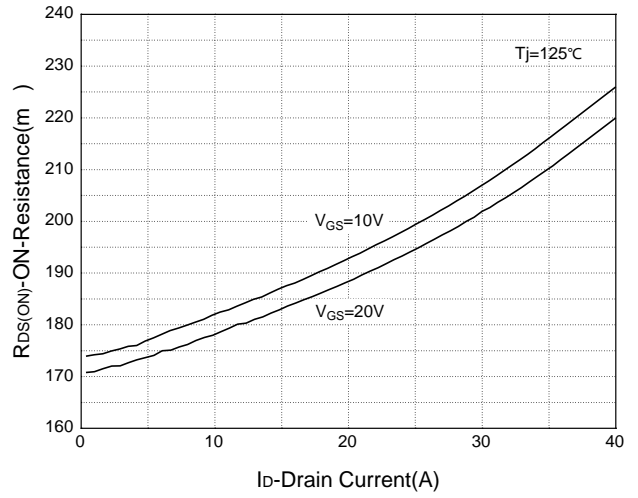


**Typical Operating Characteristics(Cont.)**

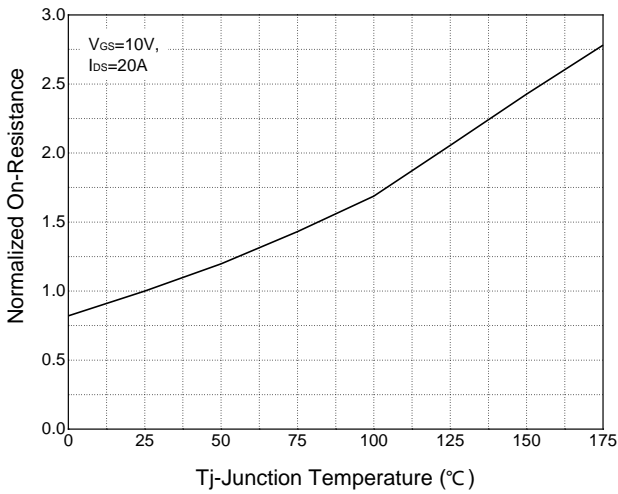
**Figure 7: Drain-Source On Resistance**



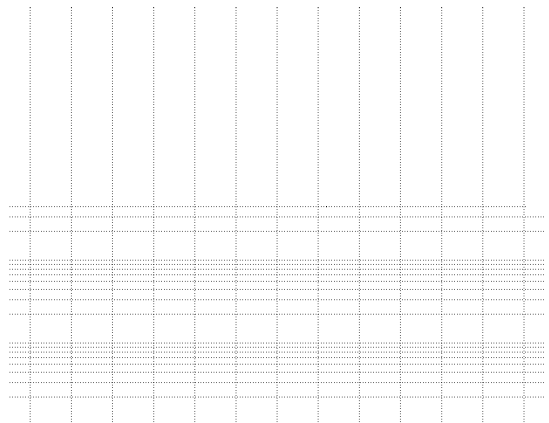
**Figure 8: Drain-Source On Resistance**



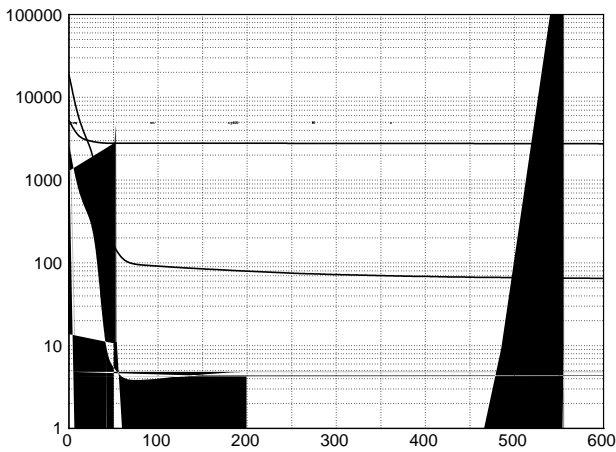
**Figure 9: On-Resistance vs. Temperature**



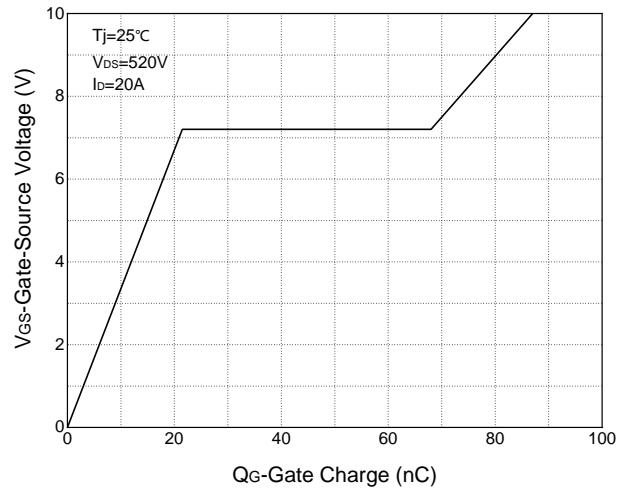
**Figure 10: Source-Drain Diode Forward**



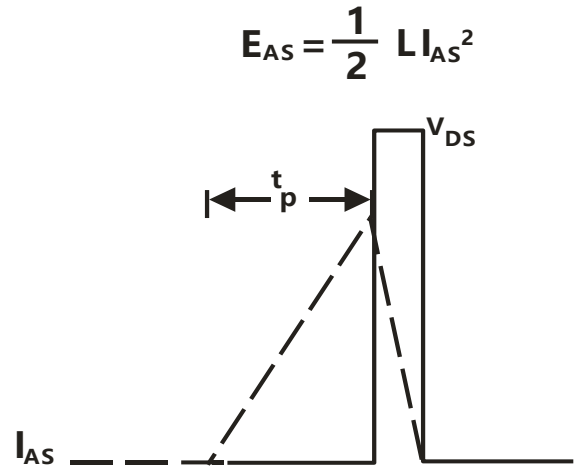
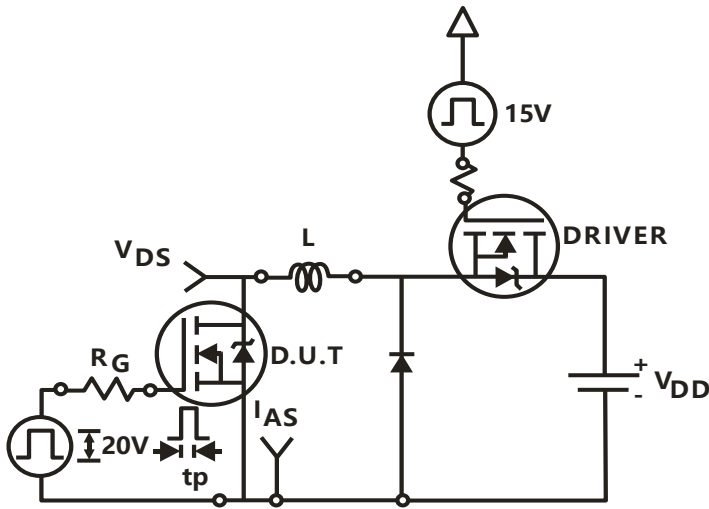
**Figure 11: Capacitance Characteristics**



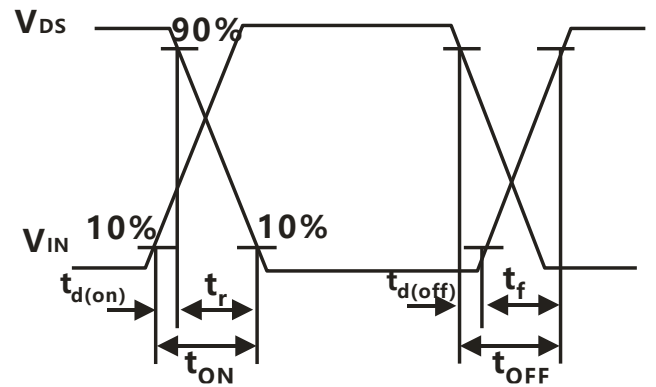
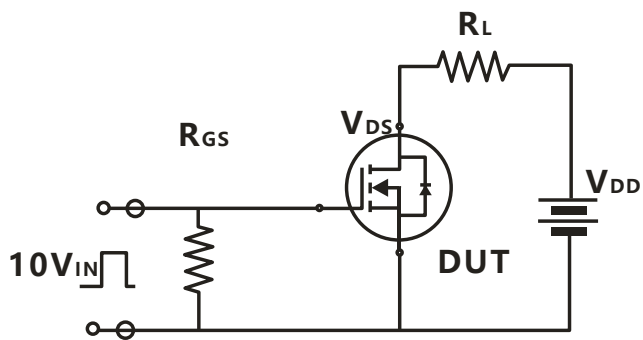
**Figure 12: Gate Charge Characteristics**



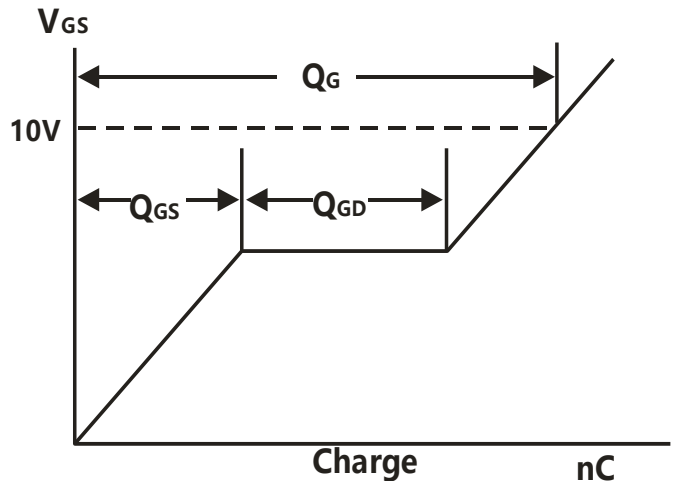
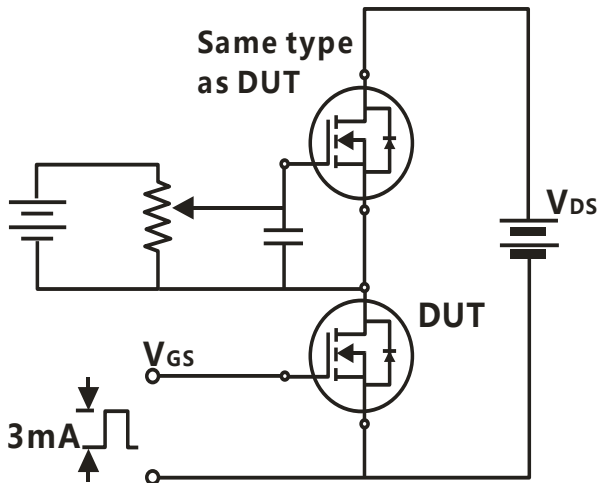
**Avalanche Test Circuit**



**Switching Time Test Circuit**



**Gate Charge Test Circuit**

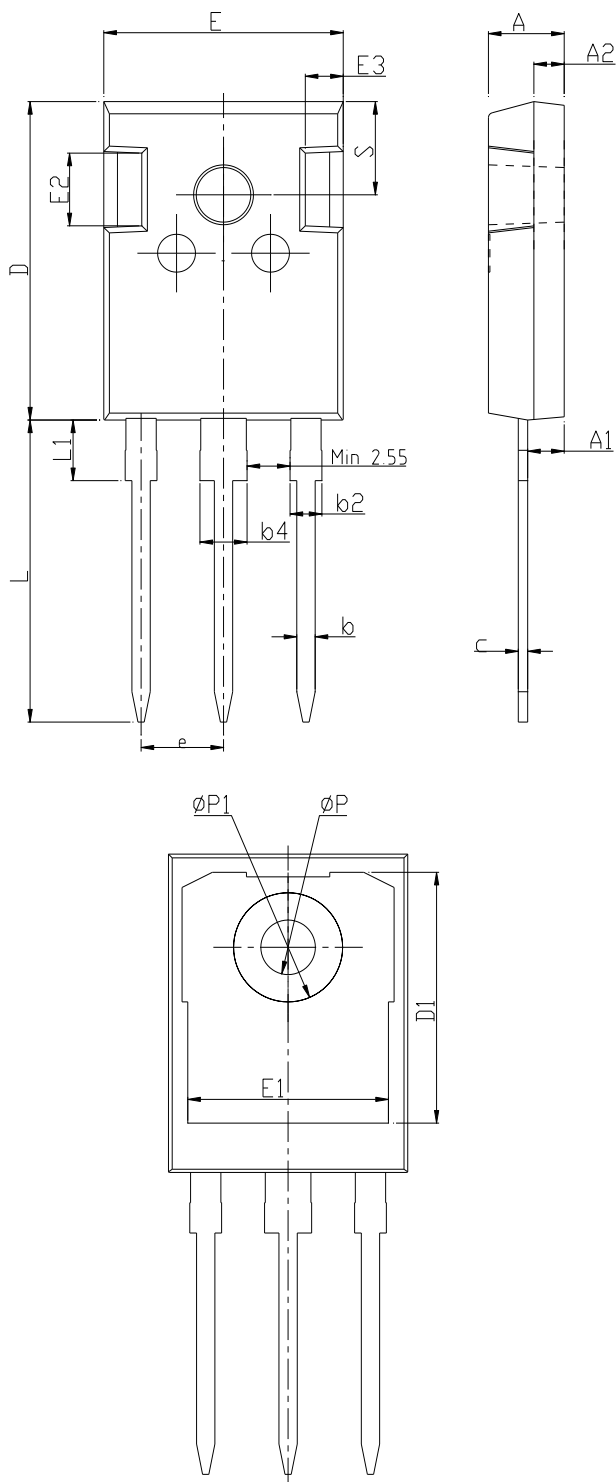


## Device Per Unit

Package Type	Unit	Quantity
TO-247A-3L	Tube	30

## Package Information

TO-247A-3L



COMMON DIMENSIONS

SYMBOL	mm		
	MIN	NOM	MAX
A	4.80	5.00	5.20
A1	2.21	2.41	2.59
A2	1.85	2.00	2.15
b	1.11	1.21	1.36
b2	1.91	2.01	2.21
b4	2.91	3.01	3.21
c	0.51	0.61	0.75
D	20.70	21.00	21.30
D1	16.25	16.55	16.85
E	15.50	15.80	16.10
E1	13.00	13.30	13.60
E2	4.80	5.00	5.20
E3	2.30	2.50	2.70
e	5.44BSC		
L	19.62	19.92	20.22
L1	-	-	4.30
P	3.40	3.60	3.80
P1	-	-	7.30
S	6.15BSC		

## Classification Profile

## Classification Reflow Profiles

Profile Feature	Sn-Pb Eutectic Assembly	Pb-Free Assembly
<b>Preheat &amp; Soak</b>		
Temperature min ( $T_{smin}$ )	100 °C	150 °C
Temperature max ( $T_{smax}$ )	150 °C	200 °C
Time ( $T_{smin}$ to $T_{smax}$ ) ( $t_s$ )	60-120 seconds	60-120 seconds
Average ramp-up rate ( $T_{smax}$ to $T_P$ )	3 °C/second max.	3°C/second max.
Liquidous temperature ( $T_L$ )	183 °C	217 °C
Time at liquidous ( $t_L$ )	60-150 seconds	60-150 seconds
Peak package body Temperature ( $T_P$ )*	See Classification Temp in table 1	See Classification Temp in table 2
Time ( $t_P$ )** within 5°C of the specified classification temperature ( $T_c$ )	20** seconds	30** seconds
Average ramp-down rate ( $T_P$ to $T_{smax}$ )	6 °C/second max.	6 °C/second max.
Time 25°C to peak temperature	6 minutes max.	8 minutes max.
*Tolerance for peak profile Temperature ( $T_P$ ) is defined as a supplier minimum and a user maximum.		
** Tolerance for time at peak profile temperature ( $t_P$ ) is defined as a supplier minimum and a user maximum.		



Table 1.SnPb Eutectic Process – Classification Temperatures (Tc)

Package Thickness	Volume mm <350	Volume mm 350
2.5 mm	235 °C	220 °C
2.5 mm	220 °C	220 °C

Table 2.Pb-free Process – Classification Temperatures (Tc)

Package Thickness	Volume mm <350	Volume mm 350-2000	Volume mm 2000
<1.6 mm	260 °C	260 °C	260 °C
1.6 mm – 2.5 mm	260 °C	250 °C	245 °C
2.5 mm	250 °C	245 °C	245 °C

## Reliability Test Program

Test item	Method	Description
SOLDERABILITY	JESD-22, B102	5 Sec, 245°C
HTRB	JESD-22, A108	168/500 Hrs, Bias @ 150°C
HTGB	JESD-22, A108	168 /500 Hrs, V <sub>gs</sub> 100% @ 150°C
PCT	JESD-22, A102	96 Hrs, 100%RH, 2atm, 121°C
TCT	JESD-22, A104	250/500 Cycles, -55°C~150°C

## Customer Service

Worldwide Sales and Service: [sales@hymexa.com](mailto:sales@hymexa.com)

Technical Support: [Technology@hymexa.com](mailto:Technology@hymexa.com)

Huayi Microelectronics Co., Ltd.

No.8928, Shangji Road, Economic and Technological Development Zone, Xi'an, China

TEL: (86-029) 86685706

FAX: (86-029) 86685705

E-mail: [sales@hymexa.com](mailto:sales@hymexa.com)

Web net: <http://www.hymexa.com/>